

The No Lead manufacturing Initiative Dr. Srinivas T. Rao

UCLA Workshop on Lead-free Solder for Electronic, Optical, and MEMs Packaging and Manufacturing September 5th 2002 Address Mfg. Needs of OEMs and EMSs

- Monitor environmental legislation and adjust activities if necessary
- Recommend an 'industry standard' lead-free alloy (reflow and wave)
- Develop criteria for industry to use to evaluate Pb-free processes
- Share information in a timely manner to promote common path to Pb-free
- Develop "best practices" experimental procedures to measure mechanical, thermal, electrical and wetting properties of Pb-free solders
- Develop solder databases for properties and literature references for lead-free alloys in the public domain
- Promote modeling for reliability through generation of best possible data and modeling methods
- Work with component and PCB suppliers to develop specifications to meet higher temperature reflow conditions



- N. American OEM's/EMS' need to prepare processes to be able to deliver Pb-free products in 2001 with an 'eye' to total Pb-elimination by 2004.
 - Japan driving "Green" consumer products.
 - Timetables seem to be holding (2001-2003)
 - NEMI companies received serious inquiries.
 - EU legislation banning lead in electronics in 2004, proposal pushed out to 2007.
 - Individual Countries can shorten timeframe.

NEMI engaged the technical side of Pb-free related to compatibility with existing assembly infrastructure.



- Europe: WEEE/ROHS. WEEE expected to come to a vote in 4Q 2002. Sticking point is the product takeback and company responsibility of ROHS.
- US: new rules regarding reporting of Pb, but no legislation on horizon for banning Pb or Pb-containing solder.
- Asia: No legislation, but Japanese companies are still actively engaged in eliminating Pb from electronics.

Push back of WEEE date + lack of other legislation has taken immediate pressure off drive to implement.

But many OEMs moving forward for marketing reasons



Major Task Group Objectives

- Demonstrate capability to deliver products in volume in 2001 with Pb-free interconnects.
- Facilitate a common Pb-free solder alloy composition for N.American electronics assembly.
- Work with component and PCB suppliers to develop specifications necessary to meet higher temperature reflow conditions.
- Develop criteria that industry can use to evaluate Pb-free processes.
- Monitor environmental legislation to adjust activities if necessary.
- Share our information in a timely manner to promote common path to Pb-free .

Commonality is an overarching goal for all NEMI activities

Worldwide Pb-free Activities

- NCMS –recent high temperature solder alloy project report released, Pb-free solders performed well.
- Gintic (Singapore) Consortium working on process and reliability of Pb-free solders.
- JEITA Continuing work on solders and tin whiskering.
- Soldertec Performed reliability tests, supported SnAgCu. Now working on Tin whiskering.
- JEDEC 020 revision with elevated temperatures for MSL testing out for ballot.
- IPC Support with meetings, standards development.
- EPA Life Cycle project. Proposal for companies to partner on a project and split cost with EPA.
- GECI Promoting global cooperation and commonality.

Cooperation/Commonality

Maximum benefit achieved through world wide agreement and cooperation.

- NEMI is member of GECI (Global Environmental Cooperation Initiative). HDPUG, SEMI, Soldertec, MEPTEC, SAC, ITRI Taiwan also members.
 - + Promoted single alloy SnAgCu
 - + Definition of Pb-free (0.2%)

Update/create JEDEC standards.

– Working with committee on J-STD-020.

Major Project Activities

- Alloy Carol Handwerker, NIST
 - Alloy Material Property development
 - Interface w/academia, gov't agencies
- Components/PCBs Rich Parker, Delphi
 - Effect of High temperature reflow
 - Pb-free terminations
- Solder Reliability John Sohn, NEMI
 - Transparent test procedure
 - Common data to share with industry
- Process Development Jasbir Bath, Solectron
 - Generic process for Reliability test boards
 - Process characterization benchmark
- Tin Whisker Swami Prasad, ChipPAC



Mission: To provide the Task Force with critical data and analyses needed for making decisions with respect to solder alloys, manufacturing, and assembly reliability.

 \checkmark NEMI chose Sn-Ag-Cu, rest of world moving in that direction.

 Developed "best practices" experimental procedures to measure the mechanical, thermal, electrical and wetting properties of leadfree solders.

Developing Solder Reliability Modeling Guidelines

✓ Critical review of reported deformation data and models



- Conducted extensive literature search including Europe and Far East
- ✓ Determined ternary eutectic melting temperature of SAC as 217⁰ C
- Investigated patent issues and selected Sn-3.9Ag-0.6Cu for reflow and Sn-0.7Cu for wave
- Examined sensitivity of melting behavior of Sn-Ag-Cu to composition and temperature in response to request from team members



Mission: To collectively work on identifying and recommending the best materials for the supplier industry to use, in delivering compatible components and PWBs that will meet the Pb-free requirements sent forth in the main task group.

- Previously characterized component survivability at elevated reflow temp.
- Characterized the optimum operating profile of maximum time, temperature and environment exposures.
- Recommendation for component temperatures
 - Reflow characterization, peak temp/board delta-T
 - JEDEC using our data for proposal for new standard, consistent with our position.

Working with IPC (ex. ITRI) PCB project for evaluation of PCB laminates.



Mission: To demonstrate capable processes for leadfree soldering of printed wiring board assemblies.

- Most thorough study of lead-free assembly to date
- Demonstrated high quality joints for reliability testing
- ✓ Report generation and review
 - ✓ X-ray solder inspection of BGAs
 - ✓ Acoustic microscopy of packages
 - ✓ AOI of solder joints
 - ✓ Solder paste performance
 - ✓ Rework



Mission: To perform reliability testing for selected solders, components and board finishes using an approved test vehicle.

✓ Thorough experiment covering various components, solder/lead combinations, failure analysis, statistical analysis.

✓ Reliability tests

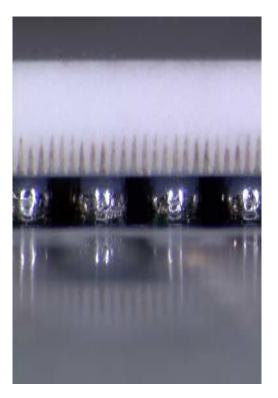
- ✓ Thermal Cycling
- ✓ Three-point Bend Testing
- ✓ Electrochemical Migration

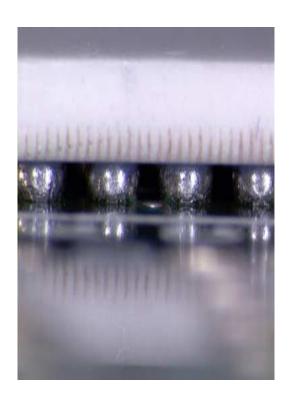
Failure analysis and root cause of TC failures

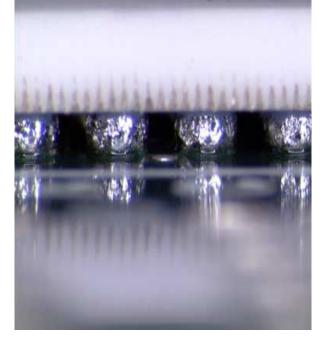
- ✓ Red dye penetrant
- ✓ Metallurgical cross-section
- ✓ Very detailed and thorough FA process.
- ✓ Statistical Data Analysis on TC results
- Data to go into alloy group database



Universal Build Visual Inspection Results: CBGA





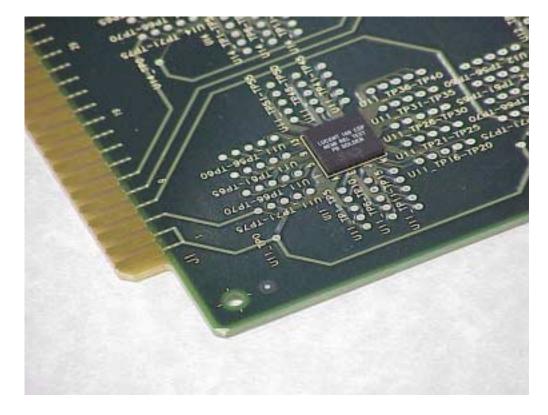


Tin-lead paste/ tin-lead CBGA (Shiny joint)

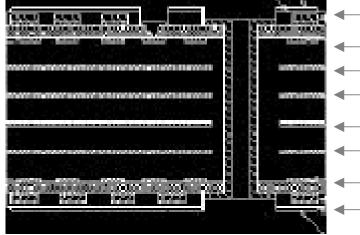
Lead-free paste/ Tin-lead CBGA (Dull joint)

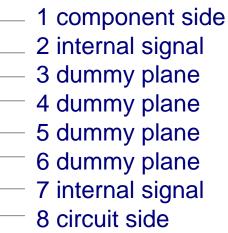
Lead-free paste/ lead-free CBGA (Cratered joint)



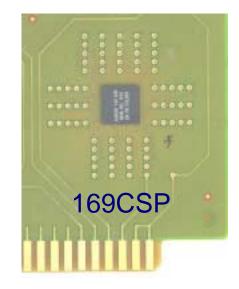








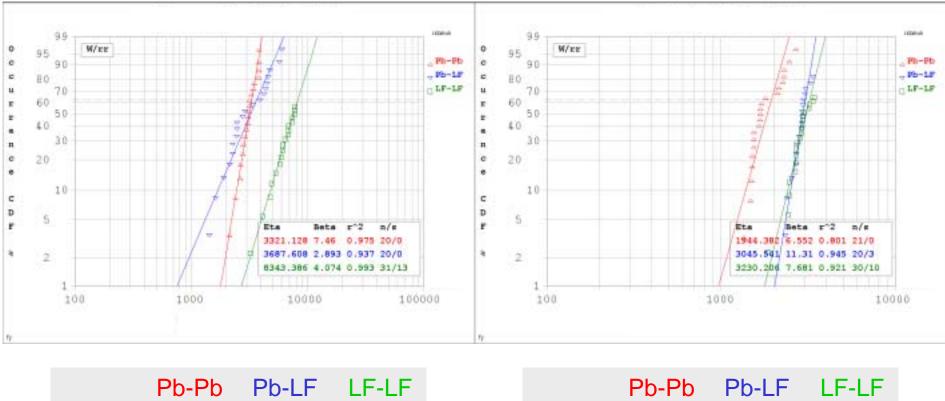
8 layer board, 0.062" thick, FR-4, Tg ~ 170°C, microvia technology Immersion silver finish





0 to100°C cycling

-40 to +125°C cycling



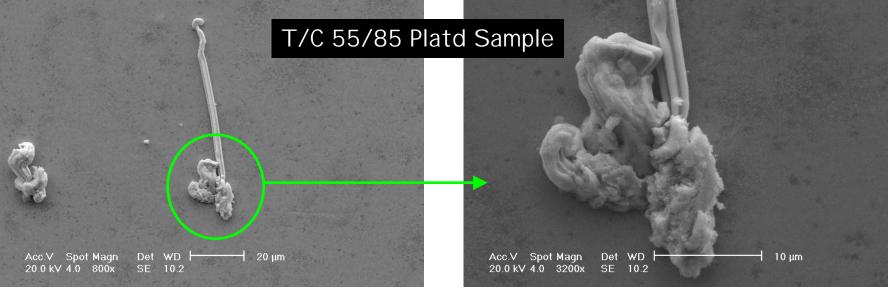
	Pb-Pb	Pb-LF	LF-LF		Pb-Pb	Pb-LF	LF-LF
η (N63)	3321	3688	8343	η (N63)	1944	3046	3230
β	7.5	2.9	4.1	β	6.6	11.3	7.7

Tin Whisker Committee: First DOE

Experimental matrix formulated after review of available whisker data in industry

- included selected IC's and passive components
- variables
 - preconditioning: ambient vs temperature cycling (500 h)
 - temperature: ambient, 50-55°C, 85°C
 - humidity: ambient, 85% RH

Accelerated conditions seem to promote whisker growth





- Recommended SAC Alloy to industry
- Demonstrated SAC Process compatible with current tools/facilities
- Interim solution to MSL problem recommended
 - Further work identified and underway
- Initiated solder joint reliability modeling effort
- Reliability evaluations find SAC alloy equal to or better than PbSn
- Member companies have released products with new alloy to production



Project Final Report – Sept 2002

Webcast Planned for Sept. 19 from Nortel in Montreal (see <u>www.nemi.org</u> for details/signup)

IEEE /Wiley Book: Q2, 2003

 Integrated book covering major points of this project along with other published work to date.